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SHEET 1 OF 1

Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.	OOCKET NO.				SERIAL NO.			
(Modified)		PATENT AND TRADE	EMARK OFFICE	247903US90CONT				10/773,293				
				APPLICANT								
LIST OF	REFE	RENCES CITED BY APP	LICANT	Tetsuo TANIGUCHI								
				FILING DATE			GROUP					
				February 9, 2004			2851					
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	AW	8-236433	09/13/1996	Japan (with English Abstract)						X		
HV	AX	9-82607	03/28/1997	Japan (with English Abstract)						x		
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